Handbook of Organizational Learning and Knowledge Management, 2nd Edition

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DESCRIPTION

The fully revised and updated version of this successful Handbook is welcomed by management scholars world-wide. By bringing together the latest approaches from the leading experts in organizational learning & knowledge management the volume provides a unique and valuable overview of current thinking about how organizations accumulate 'knowledge' and learn from experience.

Key areas of update in the new edition are:

- Resource based view of the firm
- Capability management
- Global management
- Organizational culture
- Mergers & acquisitions
- Strategic management
- Leadership
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NEW TO EDITION

Key areas of update in the new edition are: Resource based view of the firm, Capability management, Global management, Organizational culture, Mergers & acquisitions, Strategic management, Leadership

FEATURES

Key areas of update for this new edition includes: - Resource based view of the firm - Capability management - Global management - Organizational culture - Mergers & acquisitions - Strategic management - Leadership

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